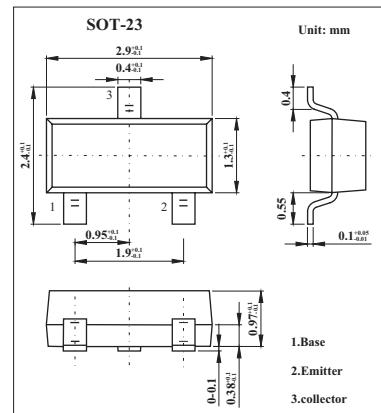


General Purpose Transistor

BCW61A/B/C/D

■ Features

- PNP Epitaxial Silicon Transistor



■ Absolute Maximum Ratings Ta = 25°C unless otherwise noted

Parameter	Symbol	Rating	Unit
Collector-Base Voltage	V _{CBO}	-32	V
Collector-Emitter Voltage	V _{CEO}	-32	V
Emitter-Base Voltage	V _{EBO}	-5	V
Collector Current	I _C	-100	mA
Collector Power Dissipation	P _C	350	mW
Storage Temperature	T _{STG}	-55 to +150	°C

BCW61A/B/C/D■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Collector cutoff current	I _{CBO}	I _E = 0; V _{CB} = -32 V			-20	nA
	I _{CBO}	I _E = 0; V _{CB} = -32 V; T _{amb} = 150 °C			-20	μA
Emitter cutoff current	I _{EBO}	I _C = 0; V _{EB} = -4 V			-20	nA
DC current gain	BCW61B	h _{FE}	I _C = -10 μA; V _{CE} = -5 V	30		
	BCW61C			40		
	BCW61D			100		
DC current gain	BCW61B	h _{FE}	I _C = -2 mA; V _{CE} = -5 V	180	310	
	BCW61C			250	460	
	BCW61D			380	630	
DC current gain	BCW61B	h _{FE}	I _C = -50 mA; V _{CE} = -5 V	80		
	BCW61C			100		
	BCW61D			110		
Collector-emitter saturation voltage	V _{CES(sat)}	I _C = -10 mA; I _B = -0.25 mA	-60		-250	mV
		I _C = -50 mA; I _B = -1.25 mA	-120		-550	mV
Base to emitter saturation voltage	V _{BES(sat)}	I _C = -10 mA; I _B = -0.25 mA	-600		-850	mV
		I _C = -50 mA; I _B = -1.25 mA	-0.68		-1.05	V
Base to emitter voltage	V _{BE}	I _C = -2 mA; V _{CE} = -5 V	-600	-650	-750	mV
Collector capacitance	C _c	I _E = i _e = 0; V _{CB} = -10 V; f = 1 MHz		4.5		pF
Emitter capacitance	C _e	I _C = i _c = 0; V _{EB} = -0.5 V; f = 1 MHz		11		pF
Transition frequency *	f _T	I _C = -10 mA; V _{CE} = -5 V; f = 100 MHz	100			MHz
Noise figure	NF	I _C = -200 μA; V _{CE} = -5 V; R _s = 2 kΩ; f = 1 kHz; B = 200 Hz		2	6	dB

* Pulse test: t_p ≤ 300 μs; d ≤ 0.02.

■ Marking

TYPE	BCW61A	BCW61B	BCW61C	BCW61D
Marking	BA	BB	BC	BD